Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/621,012	RYAN ET AL.	
Examiner	Art Unit	
Denise Tran	2185	

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
-					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (USPAT, USPGPUB, JPAB, EPAB, IBM-TDB	2/20/2006	DT		
711/202;710/305,316 (text search only - search history printout)	2/20/2006	DT		
inventor name search	2/20/2006	DT		